

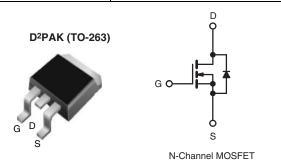
RoHS[®]

COMPLIANT

HALOGEN FREE

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	400	400		
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	1.8		
Q _g (Max.) (nC)	20			
Q _{gs} (nC)	3.3			
Q _{gd} (nC)	11			
Configuration	Single			



FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D²PAK (TO-263) is a surface mount power package capable of accommodating die size up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²PAK (TO-263) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

ORDERING INFORMATION			
Package	D ² PAK (TO-263)	D ² PAK (TO-263)	D ² PAK (TO-263)
Lead (Pb)-free and Halogen-free	SiHF720S-GE3	SiHF720STRR-GE3 ^a	SiHF720STRL-GE3 ^a
Lead (Pb)-free	IRF720SPbF	IRF720STRRPbFa	-
	SiHF720S-E3	SiHF720STR-E3a	-

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	400	V	
Gate-Source Voltage			V_{GS}	± 20	7 v	
Continuous Drain Current V _{CS} at 10 V		$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	_	3.3		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	ID	2.1	Α	
Pulsed Drain Current ^a			I _{DM}	13	1	
Linear Derating Factor				0.40	W/°C	
Linear Derating Factor (PCB Mount)e				0.025	VV/ C	
Single Pulse Avalanche Energy ^b			E _{AS}	190	mJ	
Avalanche Current ^a			I _{AR}	3.3	А	
Repetitive Avalanche Energy ^a		E _{AR}	5.0	mJ		
Maximum Power Dissipation	T _C = 25 °C		В	50	w	
Maximum Power Dissipation (PCB Mount)e	T _A =	25 °C	P_{D}	3.1	l vv	
Peak Diode Recovery dV/dt ^c			dV/dt	4.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d]	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 30 \,\text{mH}$, $R_g = 25 \,\Omega$, $I_{AS} = 3.3 \,\text{A}$ (see fig. 12).
- c. $I_{SD} \le 3.3$ A, $dI/dt \le 65$ A/ μ s, $V_{DD} \le V_{DS}$, $T_{J} \le 150$ °C.
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRF720S, SiHF720S

Vishay Siliconix



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	40	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.5	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0, I _D = 250 μA		400	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.51	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zova Cata Valtaga Dvain Cuwant	1	V _{DS} = 400 V, V _{GS} = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 320 \	V _{DS} = 320 V, V _{GS} = 0 V, T _J = 125 °C			250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.0 A ^b	-	-	1.8	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 2.0 A ^b	1.7	-	-	S
Dynamic		•					
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	410	-	
Output Capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$		120	-	рF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	47	-	
Total Gate Charge	Qg			-	-	20	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_{D} = 3.3 \text{ A}, V_{DS} = 320 \text{ V},$ see fig. 6 and 13 ^b		-	3.3	nC
Gate-Drain Charge	Q _{gd}	7			-	11	
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r	$V_{DD} = 200 \text{ V}, I_D = 3.3 \text{ A},$ $R_g = 18 \Omega, R_D = 56 \Omega, \text{ see fig. } 10^{\text{b}}$		-	14	-	ns
Turn-Off Delay Time	t _{d(off)}			-	30	-	
Fall Time	t _f	7		-	13	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	الم
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s	•					
Continuous Source-Drain Diode Current	Is	MOSFET sym showing the	bol	-	-	3.3	A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	13	^
Body Diode Voltage	V _{SD}	T _J = 25 °C	$I_{S} = 3.3 \text{ A}, V_{GS} = 0 \text{ V}^{b}$	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _ 05 °C !	_ 2 2 A dI/d+ 100 A/h	-	270	600	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 3.3 \text{A}, dI/dt = 100 \text{A}/\mu\text{s}^b$		-	1.4	3.0	μC
		Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

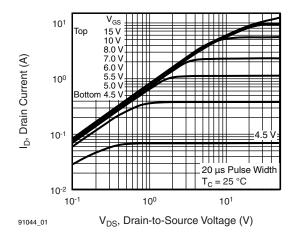


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

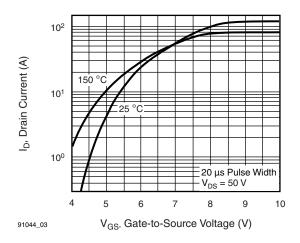


Fig. 3 - Typical Transfer Characteristics

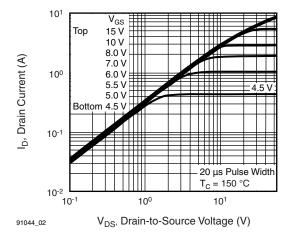


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

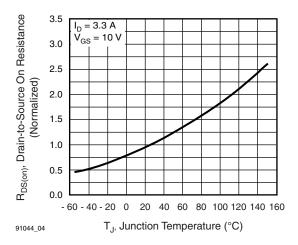


Fig. 4 - Normalized On-Resistance vs. Temperature



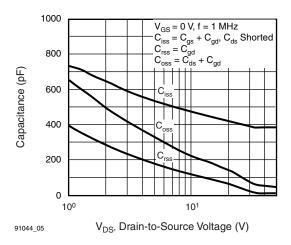


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

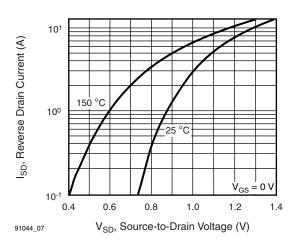


Fig. 7 - Typical Source-Drain Diode Forward Voltage

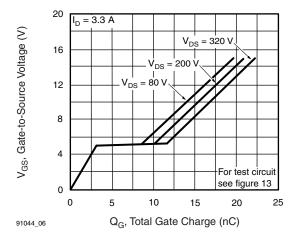


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

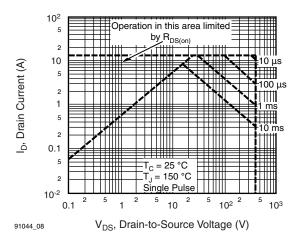


Fig. 8 - Maximum Safe Operating Area





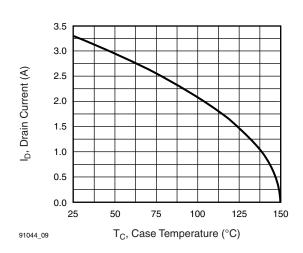


Fig. 9 - Maximum Drain Current vs. Case Temperature

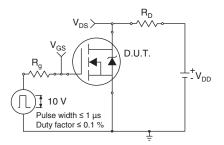


Fig. 10a - Switching Time Test Circuit

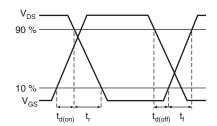


Fig. 10b - Switching Time Waveforms

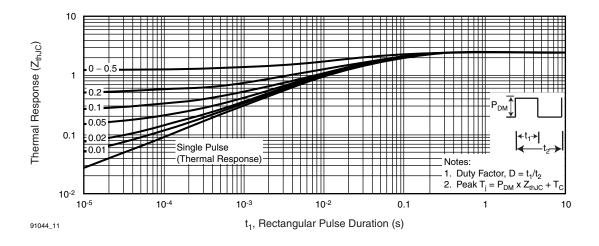
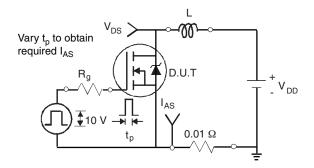


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





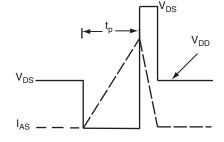


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

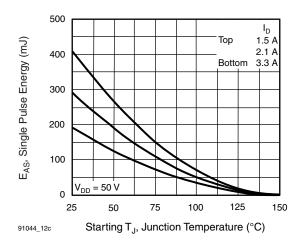


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

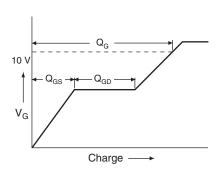


Fig. 13a - Basic Gate Charge Waveform

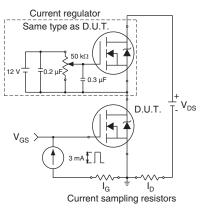
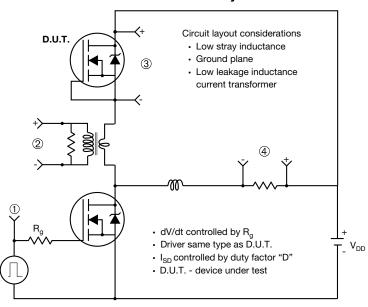


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



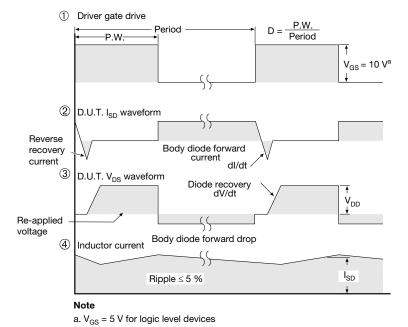
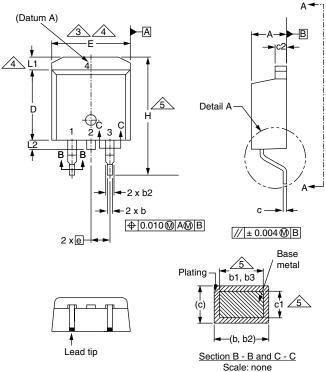


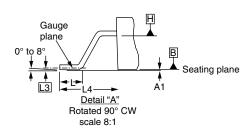
Fig. 14 - For N-Channel

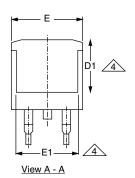
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TO-263AB (HIGH VOLTAGE)







lating –	b1, b3	/ metal
(c)		of 25
Ļ	← (b, b2) →	
Sect	ion B - B ar	
	Scale: nor	ne

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380
ECN: S-82110-Rev. A, 15-Sep-08				

MIN. 0.270	MAX.
	-
700	
0.360	0.420
0.245	ı
0.100 BSC	
0.575	0.625
0.070	0.110
-	0.066
-	0.070
0.010	BSC
0.188	0.208
	0.100 0.575 0.070 - - 0.010

DWG: 5970 Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

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Revision: 02-Oct-12 Document Number: 91000